## Abstract of the Disclosure

In the single crystal SiC according to the invention, heat treatment is performed in an inert gas atmosphere under a state where a cutting plane of a single crystal  $\alpha$ -SiC substrate which is produced in a plate-like form by cutting along (1 1  $\bar{2}$  0) Miller index plane  $\pm$  10°, and (2 2 0) Miller index plane of a polycrystalline  $\beta$ -SiC plate are superimposed on each other, whereby single crystal having a crystal orientation of an orientation of the cutting plane is integrally grown in the polycrystalline  $\beta$ -SiC plate in conformity with the single crystal  $\alpha$ -SiC substrate. According to this configuration, single crystal SiC of very high quality is obtained to which influence of micropipes of the single crystal  $\alpha$ -SiC substrate is not transferred, thereby preventing distortion and micropipe defects from occurring.

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